Pictorial Structures for Object Recognition

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Introduction

- Problem : recognizing objects using generic part-based models.
- Motivation: pictorial structure representation (Fischler and Elschlager) (1973).

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Pictorial Structures

Definition

- Collection of parts with connections between certain pairs of parts
- Fischler and Elschlager (1973) problem defined in terms of an energy to be minimized.
- Used to represent generic objects.

$$L^* = \arg\min_{L} \left(\sum_{i=1}^{n} m_i(l_i) + \sum_{(v_i, v_j) \in E} d_{ij}(l_i, l_j) \right)$$
 (1)

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Efficient Algorithm

Definition

- T_{ij} and T_{ji} are one-to-one.
- Let M_{ij} be a diagonal matrix

Mahalanobis distance:

$$d_{ij}(I_i, I_j) = T_{ij}(I_i) - T_{ji}(I_j)^{\top} M_{ij}^{-1} (T_{ij}(I_i) - T_{ji}(I_j))$$
(2)

Statistical Framework

Definition

- ullet Let θ be a set of parameters that define an object model;
- I denote an image;
- L denote a configuration of the object (a location for each part).

By Baye's Rule:

$$p(L \mid I, \theta) \propto \underbrace{p(I \mid L, \theta)}_{\text{potential}} \underbrace{p(L \mid \theta)}_{\text{prior}} \tag{3}$$

Statistical Framework

Definition

- The pictorial structure is parametrized $\theta = (u, E, c)$
- $u = \{u_1, ..., u_n\}$ are appearance parameters;
- E is set of edges E indicates which parts are connected
- $c = \{c_{ij} | (v_i, v_j) \in E\}$ are connection parameters.

We can write the prior distribution over object configurations by a tree-structured Markov random field with edge set E:

$$p(L \mid \theta) = p(L \mid E, c) = \frac{\prod_{(v_i, v_j) \in E} p(l_i, l_j \mid \theta)}{\prod_{v_i \in V} p(l_i \mid \theta)^{\deg v_i - 1}} = \prod_{(v_i, v_j) \in E} p(l_i, l_j \mid \theta)$$

(4)



Statistical Framework

So, we can rewrite the Baye's Rule (6), and that the likelihood of an image can be seen as the product of the individual likelihoods:

$$P(L \mid I, \theta) \propto \left(\prod_{i=1}^{n} p\left(I \mid I_{i}, u_{i}\right) \prod_{\left(v_{i}, v_{j}\right) \in E} p\left(I_{i}, I_{j} \mid c_{ij}\right) \right)$$
 (5)

We can easily that is an equivalent to the energy function that is being minimized in equation (1), where $m_i(l_i) = log \ p(l|l_i,u_i)$ is a match cost measuring how well part v_i matches the image data at location l_i , and $d_{ij}(li,lj) = log \ p(li,lj|c_{ij})$ is a deformation cost measuring how well the relative locations for v_i and v_j agree with the prior model.

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Learning Model Parameters

Given a set of example images $\{I_1,...,I_m\}$ and the corresponding configurations $\{L_1,...,L_m\}$ of the object and the model parameters $\theta=(u,E,c)$, assuming that each example was generated independently

$$\rho\left(I^{1},\ldots,I^{m},L^{1},\ldots,L^{m}\mid\theta\right)=\prod_{k=1}^{m}\rho\left(I^{k},L^{k}\mid\theta\right),$$

Using the Baye's Rule $p(I, L \mid \theta) = p(I \mid L, \theta)p(L \mid \theta)$, we can estimate the Maximum Likelihood:

$$\theta^* = \arg\max_{\theta} \prod_{k=1}^{m} p\left(I^k \mid L^k, \theta\right) \prod_{k=1}^{m} p\left(L^k \mid \theta\right)$$
(6)

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Learning Model Parameters

Estimating the Dependencies

Goal: pick a set of edges that form a tree and the connection parameters for each edge (algorithm of Chow and Liu) described in, which estimates a tree distribution for discrete random variables. From equation (6) we get

$$E^*, c^* = \arg \max_{E,c} \prod_{k=1}^m p\left(L^k \mid E, c\right).$$

Rewriting using the prior:

$$E^*, c^* = \arg \max_{E, c} \prod_{(v_i, v_j) \in E} \prod_{k=1}^{m} p(I_i^k, I_j^k \mid c_{ij}).$$

We can characterize the "quality" $q(v_i, v_j)$ of a connection between two parts as the probability of the examples under the ML estimate for their joint distribution.

$$E^* = \arg\max_{E} \prod_{\left(v_i, v_i\right) \in E} q\left(v_i, v_j\right) = \arg\min_{E} \sum_{\left(v_i, v_i\right) \in E} -\log q\left(v_i, v_j\right)$$

Solving for E is equivalent to compute the minimum spanning tree (MST) of a graph, We build a complete graph on the vertices V, weight $logq(v_i, v_j)$, with each edge (v_i, v_j) .

- Kruskal's $\mathcal{O}(n^2 \log n)$

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Learning Model Parameters

Estimating the Appearance Parameters

The u^* can independently solve for the u_i^* ,

$$u_i^* = \arg \max_{u_i} \prod_{k=1}^m p\left(I^k \mid I_i^k, u_i\right).$$

This is exactly the ML estimate of the appearance parameters for part v_i , given independent examples $\left\{ \left(I^1, I_i^1\right), \ldots, \left(I^m, I_i^m\right) \right\}$.

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Energy Minimization or MAP Estimate

Problem Equation:

$$L^* = \arg\min_{L} \left(\sum_{i=1}^{n} m_i(l_i) + \sum_{(v_i, v_j) \in E} d_{ij}(l_i, l_j) \right)$$

- Equation Components:
 - m_i(l_i): Match cost for part i at l_i.
 - $d_{ii}(I_i, I_i)$: Deformation cost between parts i and j.
 - E: Edges connecting parts.
 - Objective: Minimize total cost for configuration L.
- Dynamic Programming Approach for Efficiency.

Dynamic Programming in Energy Minimization

• Leaf Node:

$$B_j(I_i) = \min_{I_j}(m_j(I_j) + d_{ij}(I_i, I_j))$$

Non-Leaf Node:

$$B_j(l_i) = \min_{l_j} \left(m_j(l_j) + d_{ij}(l_i, l_j) + \sum_{\nu_c \in C_j} B_c(l_j) \right)$$

Root Node:

$$L^* = \arg\min_{l_r} \left(m_r(l_r) + \sum_{v_c \in C_r} B_c(l_r) \right)$$

- Complexity:
 - Time: $O(nh^2)$.
 - Due to h^2 combinations per node for n nodes.

Posterior Sampling in Pictorial Structures

Problem Formulation:

$$p(L|I,\theta) \propto \prod_{i=1}^{n} p(I|I_i, u_i) \prod_{(v_i, v_j) \in E} p(I_i, I_j|c_{ij})$$

- Key Elements:
 - $p(I|I_i, u_i)$: Likelihood of observing I given part i at I_i .
 - $p(l_i, l_i | c_{ii})$: Probability of relative locations of connected parts.
 - Objective: Sample configurations L from this posterior distribution.
- Approach:
 - Algorithm similar to energy minimization, but uses probabilities and summations.
 - Based on a tree structure of dependencies between parts.

Computing and Sampling in Posterior Distribution

Root Sampling:

$$p(I_r|I,\theta) \propto p(I|I_r,u_r) \prod_{v_c \in C_r} S_c(I_r)$$

S Function for Nodes:

$$S_j(l_i) \propto \sum_{l_j} p(l|l_j, u_j) p(l_i, l_j|c_{ij}) \prod_{v_c \in C_j} S_c(l_j)$$

• Child Node Sampling:

$$p(l_j|l_i,l,\theta) \propto p(l|l_j,u_j)p(l_i,l_j|c_{ij}) \prod_{v_c \in C_i} S_c(l_j)$$

- Complexity:
 - Time: O(h' * n) using Gaussian convolution in transformed space.
 - Efficient computation via separable Gaussian filter and discrete grid.

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Iconic Models

- Parts Location: Defined by (x, y) in a two-dimensional pose space.
- Iconic Representation:
 - Based on Gaussian derivative filters responses.
 - Image patch represented as a 27-dimensional vector (using scales $\sigma_1 = 1, \sigma_2 = 2, \sigma_3 = 4$).
 - Iconic index insensitive to lighting, scale changes, and deformations.
- Appearance Model:

$$p(I|I_i, u_i) \propto N(\alpha(I_i), \mu_i, \Sigma_i)$$

- $\alpha(I_i)$: Iconic index at location I_i .
- $u_i = (\mu_i, \Sigma_i)$: Gaussian model parameters for each part.

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Iconic Models - Spatial Relations and Experiments

Spatial Relations:

$$p(I_i,I_j|c_{ij}) = N(I_i - I_j,s_{ij},\Sigma_{ij})$$

- Connections modeled by springs between parts.
- $c_{ij} = (s_{ij}, \Sigma_{ij})$: Parameters for each connection.
- Deformations modeled by Gaussian distribution with full covariance matrix.
- Transformation for Algorithm Compatibility:

$$T_{ij}(I_i) = U_{ij}^T(I_i - s_{ij}), \quad T_{ji}(I_j) = U_{ij}^T(I_j)$$

- U_{ij} : From SVD of Σ_{ij} .
- Experiments:
 - ML estimation for model training.
 - Models tested on face detection with varying conditions.
 - Demonstrated robustness in occlusion and multiple face detection.

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Figure: Three examples from the first training set showing the locations of the labeled features and the structure of the learned model.



Figure: Matching results demonstrating the model's effectiveness in detecting facial features.



Figure: Matching results on occluded faces, illustrating the model's robustness in handling partial occlusions.



Figure: Matching results on an image with multiple faces, showcasing the model's capability in complex scenarios.

Articulated Models

Definition

• (x'_i, y'_i) and (x'_i, y'_i) are the positions of the joints.

$$p(I_{i}, I_{j} \mid c_{ij}) = \mathcal{N}(x'_{i} - x'_{j}, 0, \sigma_{x}^{2})$$

$$\mathcal{N}(y'_{i} - y'_{j}, 0, \sigma_{y}^{2})$$

$$\mathcal{N}(s'_{i} - s'_{i}, 0, \sigma_{s}^{2})$$
(7)

In the right form:

$$p(I_i, I_j \mid c_{ij}) \propto \mathcal{N}(T_{ji}(I_j) - T_{ij}(I_i), 0, D_{ij})$$
(8)

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 $\mathcal{M}(\theta_i' - \theta_i', 0, \sigma_\theta^2)$

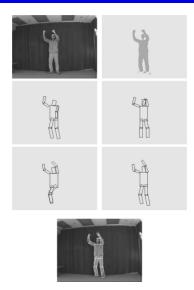


Figure: Input image, binary image, random samples from the posterior distribution of configurations, and best result selected using the Chamfer distance

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Variety of Poses

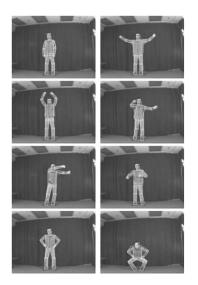


Figure: Matching results



Drawbacks

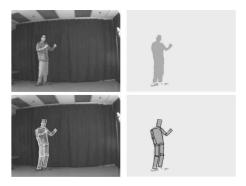


Figure: In this case, the binary image doesn't provide enough information to estimate the position of one arm.

Drawbacks

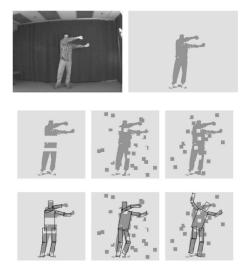


Figure: Matching results on corrupted images.

Conclusions

- Main Contributions
 - Introduce Efficient Algorithms
 - Use of statistical sampling
 - Use of stastistical formulation from labeled example images
- Models based on the pictorial structure representation Fischler and Elschlager (1973)
- Statistical framework for representing visual appearance

References

 Felzenszwalb, P.F., Huttenlocher, D.P. (2005). Pictorial Structures for Object Recognition. International Journal of Computer Vision, 61, 55–79. https://doi.org/10.1023/B:VISI.0000042934.15159.49

Appendix

Learning Model Parameters - Estimating the Appearance Parameters From equation (6) we get

$$u^* = \arg\max_{u} \prod_{k=1}^{m} p\left(I^k \mid L^k, u\right),$$

The likelihood of seeing image I^k , given the configuration L^k for the object is given by the product of the likelihoods

$$u^* = \arg\max_{u} \prod_{k=1}^{m} \prod_{i=1}^{n} \rho\left(I^k \mid I_i^k, u_i\right) = \arg\max_{u} \prod_{i=1}^{n} \prod_{k=1}^{m} \rho\left(I^k \mid I_i^k, u_i\right).$$

Looking at the right hand side we see that to find u^* we can independently solve for the u_i^* ,

$$u_i^* = \arg\max_{u_i} \prod_{k=1}^m p\left(I^k \mid I_i^k, u_i\right).$$

This is exactly the ML estimate of the appearance parameters for part v_i , given independent examples $\{(I^1, I_i^1), \ldots, (I^m, I_i^m)\}$.

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Generalized Distance Transforms

• Traditional Distance Transforms:

$$D_B(x) = \min_{y \in B} \rho(x, y)$$

- $\rho(x,y)$: Distance measure on grid G.
- $B \subseteq G$: Set of points.
- $D_B(x)$: Distance to nearest point in B.
- Generalized Form:

$$D_f(x) = \min_{y \in G} (\rho(x, y) + f(y))$$

- f(y): Arbitrary function over grid G.
- Optimizes distance and function value.
- Application to Dynamic Programming:

$$B_j(I_i) = D_f(T_{ij}(I_i))$$

- $B_i(I_i)$: Computed using generalized distance transform.
- $T_{ii}(I_i)$: Transformation in the grid.
- Efficient computation under Mahalanobis distance.

Computing the S Functions

S Function Formulation:

$$S_j(l_i) \propto \sum_{l_j} N(T_{ij}(l_i) - T_{ji}(l_j), 0, D_{ij}) p(I|l_j, u_j) \prod_{v_c \in C_j} S_c(l_j)$$

- Gaussian convolution in transformed space.
- T_{ij} and T_{ji} : Transformations.
- D_{ij}: Covariance in Gaussian filter.
- Convolution and Efficiency:

$$S_j(I_i) \propto (F \otimes f)(T_{ij}(I_i))$$

- F: Gaussian filter.
- ⊗: Convolution operator.
- Efficient computation on a discrete grid.
- Algorithm Complexity:
 - Time: O(h' * n).
 - Efficient for large models and configurations.



Questions